

SYNCHRONIZING CIRCUITS AND METHODS FOR PARALLEL PATH ANALOG-TO-DIGITAL CONVERTERS

Related Application

This application claims the benefit of Korean Patent Application No. 2003-0008630, filed February 11, 2003, the disclosure of which is hereby incorporated herein by reference in its entirety as if set forth fully herein.

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Field of the Invention

The present invention relates to Analog-to-Digital (A/D) converters, and more particularly to parallel path A/D converters.

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Background of the Invention

Analog-to-Digital (A/D) converters are widely used to convert an analog input signal to a multi-bit digital output signal. As is well known to those having skill in the art, a class of A/D converters is a parallel path A/D converter, also referred to herein as a multi-process A/D converter. In a parallel path A/D converter, a plurality of signal paths are responsive to an analog input signal, to generate a multi-bit digital signal therefrom. A respective signal path includes therein a comparator.

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FIG. 1 illustrates an example of a conventional multi-process A/D converter. As shown in FIG. 1, the A/D converter receives an analog input signal **SI** from, for example, an external terminal, converts the received input signal into digital signals via multiple paths comprised of a plurality of process routines **102**, **104** and **106**, a plurality of comparators **108**, **110** and **112**, and a plurality of decoders **114**, **116** and **118**, and then generates an n-bit digital output signal **DO[0:n-1]** therefrom.

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A/D-converted digital signals **PO1-PO(N)** are generated from the plurality of comparators **108**, **110** and **112** respectively connected to the process routines **102**, **104** and **106**. The A/D-converted digital signals **PO1-PO(N)** are compared and analyzed in a synchronizing circuit **122**, so that synchronized signals **CSO1** to **CSO(N)** are generated from the synchronizing circuit **122**, and then applied to the decoders **114**, **116** and **118** respectively corresponding to the process routines **102**, **104** and **106**.

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Digital output signals **DO[0:i-1]-DO[m:n-1]** generated from the decoders **114**, **116** and **118**, corresponding to the respective process routines, constitute the n-bit digital output signal **DO[0:n-1]**.

The analog input signal **SI** propagates with different time delays while passing
5 through the different signal paths, having different signal distortions from one another. However, in the conventional A/D converter of FIG. 1, since the comparators **108**, **110** and **112**, the decoders **114**, **116** and **118**, and the synchronizing circuit **122** are controlled on respective paths by the same internal clock signal **ICLK** provided by a clock buffer **120**, an erroneous conversion of the signals may occur,
10 which may result in the generation of erroneous signals. The conventional synchronizing circuit **122** of FIG. 1 generally performs a latching function of synchronizing the output signals of the comparators to a clock signal, and a function of correcting the generated erroneous signals.

FIG. 2 is a block diagram illustrating an example of a conventional parallel
15 path A/D converter with folding/interpolation and flash process routines. The A/D converter of FIG. 2 receives an analog input signal **SI** from, for example, an external terminal, converts the received signal **SI** into a digital signal via both paths of the folding/interpolation process routine **202** and the flash process routine **204**, and then generates a digital output signal **DO** of a desired bit-number therefrom. Also, in the
20 A/D converter of FIG. 2, the analog input signal **SI** propagates with different time delays while passing through the different signal paths, being distorted with different patterns from one another. However, in the conventional A/D converter of FIG. 2, since the comparators **206** and **208**, the decoder **214** and the synchronizing circuit **212** are controlled on each path by the same internal clock signal **ICLK** provided by a
25 clock buffer **210**, an erroneous conversion of the signals may occur, which may result in the generation of erroneous signals. The conventional synchronizing circuit **212** of FIG. 2 compares the signals, which are input through different paths from each other, to synchronize them to the clock signal.

FIG. 3 is a timing diagram that illustrates a process of synchronization
30 according to a synchronizing circuit of FIG. 2. FIG. 4 illustrates a synchronizing circuit of FIG. 2 using a logic circuit.

In FIG. 3, it is assumed that the Most Significant Bit (MSB) and the second most significant bit **MSB-1** are a signal **PO1** passing via the folding/interpolation process routine **202** and the comparator **206** of FIG. 2, and that the third most

significant bit **MSB-2** is a signal **PO2** passing via the flash process routine **204** and the comparator **208**. In FIG. 3, the **MSB** and the **MSB-1** are synchronized to each other, but the **MSB** and the **MSB-2**, or the **MSB-1** and the **MSB-2** are not synchronized to each other. Accordingly, such asynchronous bit patterns may cause the converted digital signals to include code glitch errors. When synchronizing errors appearing at time points **T3-T2** are present, it defines a time region **A** including the asynchronous time points **T1-T4**. Then, a synchronizing operation is performed for the region to be corrected by the synchronizing circuit as shown in FIG. 4.

In FIG. 4, it is assumed that the signal **PO1** indicates the **MSB**, the signal **PO2** indicates the **MSB-2**, and that the signal **SA** represents "1" within a range of the time region **A** while the signal **SA** represents "0" out of the range of the time region **A**. In synchronizing the **MSB** with the **MSB-2**, the **MSB-2** is logically ORed with the **MSB** in the time region **A** after developing the same phase with the **MSB** by logic inversion. As a result of the OR operation, the **MSB** having an edge trigger later than the **MSB-2** within the region **A** is synchronized to the **MSB-2**. Thus, the code glitch error can be corrected.

Unfortunately, it may be difficult to extend the range of error correction because the correcting region may be set for synchronization and the correcting region may be narrow. Furthermore, the conventional A/D converter may not conformably address the asynchronous signal, but may only correct the code glitch errors.

Summary of the Invention

Some embodiments of the present invention provide an A/D converter that includes a plurality of signal paths that are responsive to an analog input signal, to generate a multi-bit digital signal therefrom. A respective signal path includes therein a comparator. A synchronizing circuit is responsive to a clock signal and outputs of the comparators, to generate a respective delayed clock signal that is applied to a respective comparator. In some embodiments, a respective signal path also includes therein a respective decoder that is responsive to a respective comparator and to the clock signal. In some embodiments, the synchronizing circuit is configured to generate a respective delay clock signal based on at least one phase difference between the outputs of the comparators.

Synchronizing methods according to some embodiments of the present invention may be used in A/D converters that include a plurality of signal paths that

are responsive to an analog input signal, to generate a multi-bit digital signal therefrom, wherein a respective path includes therein a comparator. According to these methods, a plurality of delayed clock signals are generated from a clock signal and outputs of the comparators. A respective one of the delayed clock signals is
5 applied to a respective comparator. In other embodiments, the clock signal is also applied to the respective decoders. In still other embodiments, the delayed clock signals are generated based on at least one phase difference between the outputs of the comparators.

Other embodiments of the present invention provide an A/D converter that
10 comprises a clock buffer that is configured to receive and buffer an external clock signal, to thereby generate an internal clock signal. A plurality of process routines are configured to receive and process an analog input signal. The plurality of comparators are configured to receive analog signals from the plurality of process routines, and to compare the received analog signals with a reference voltage, to
15 thereby generate digital signals therefrom, under control of a respective one of delayed clock signals. A plurality of decoders are configured to receive the digital signals from the plurality of comparators, and to convert the received digital signals into a code format, to thereby generate converted digital signals. A synchronizing circuit is configured to receive the internal clock signal from the clock buffer and the
20 digital signals from the plurality of comparators, and to generate the respective delayed clock signals therefrom.

In still other embodiments, the synchronizing circuit includes a phase detector that is configured to receive the digital signals from the plurality of comparators and to detect a phase difference between the digital signals. A delay controller is
25 configured to receive an output signal of the phase detector and to generate a respective time delay control signal for a respective one of the process routines, corresponding to the phase difference. A plurality of delay chain parts are configured to receive the internal clock signal from the clock buffer, and to generate the respective delayed clock signals, under control of a respective one of the time delay
30 control circuits.

Brief Description of the Drawings

FIG. 1 is a block diagram illustrating an example of a conventional multi-process A/D converter;

FIG. 2 is a block diagram illustrating an example of a conventional A/D converter comprised of folding/interpolation and flash process routines;

FIG. 3 is a timing diagram illustrating a method of synchronization using a synchronizing circuit of FIG. 2;

FIG. 4 is a circuit diagram illustrating a synchronizing circuit of FIG. 2 using a logic circuit;

FIG. 5 is a block diagram illustrating A/D converters according to some embodiments of the present invention;

FIG. 6 is a block diagram illustrating A/D converters comprised of folding/interpolation and flash process routines according to other embodiments of the present invention; and

FIG. 7 is a circuit diagram illustrating synchronizing circuits of FIG. 6 using logic circuits, according to some embodiments of the present invention.

15 Detailed Description

The present invention now will be described more fully hereinafter with reference to the accompanying drawings, in which embodiments of the invention are shown. This invention may, however, be embodied in many different forms and should not be construed as limited to the embodiments set forth herein. Rather, these
20 embodiments are provided so that this disclosure will be thorough and complete, and will fully convey the scope of the invention to those skilled in the art. Like numbers refer to like elements throughout. It will be understood that when an element is referred to as being "connected", "coupled" or "responsive" to another element, it can be directly connected, coupled or responsive to the other element or intervening
25 elements may be present. In contrast, when an element is referred to as being "directly connected", "directly coupled" or "directly responsive" to another element, there are no intervening elements present.

FIG. 5 is a block diagram illustrating A/D converters according to some embodiments of the present invention. As shown in FIG. 5, A/D converters according to some embodiments of the present invention include a plurality of signal paths that are responsive to an analog input signal **SI**, to generate a multi-bit digital signal **DO[0:n-1]** therefrom. A respective signal path includes therein a comparator **508**, **510** and **512**. A synchronizing circuit **522** is responsive to a clock signal, such as an internal clock signal **ICLK** provided by a clock buffer **520**, and outputs **PO1-PO(N)**

of the comparators **508**, **510** and **512**, to generate a respective delayed clock signal **DCLK1...DCLK(N)**, that is applied to a respective comparator **508**, **510** and **512**. As also shown in FIG. 5, in some embodiments, a respective signal path also includes therein a respective decoder **514**, **516** and **518** that is responsive to a respective
5 comparator **508**, **510** and **512** and to the clock signal **ICLK**. Finally, as also shown in FIG. 5 in other embodiments, the synchronizing circuit **522** is configured to generate a respective delayed clock signal **DCLK1...DCLK(N)** based on at least one phase difference between the outputs **PO1...PO(N)** of the comparators **508**, **510** and **512**. It will be understood that although three signal paths are illustrated in FIG. 5, fewer
10 paths or more paths may be provided according to embodiments of the invention.

More specifically, referring to FIG. 5, in some embodiments, an A/D converter includes **N** process routines ($N \geq 2$) and generates an **n**-bit digital signal therefrom. As shown in FIG. 5, some embodiments of an A/D converter include the clock buffer **520** that is configured to receive and buffer an external clock signal
15 **CLK**, to thereby generate the internal clock signal **ICLK** therefrom. A plurality of process routines **502**, **504** and **506** are configured to receive and process the analog input signal **SI**. The plurality of comparators **508**, **510** and **512** are configured to receive the analog signals from the plurality of process routines **502**, **504** and **506**, and to compare the received analog signals with a reference voltage under control of one
20 of the delayed clock signals **DCLK1...DCLK(N)**, to thereby generate digital signals **PO1...PO(N)** therefrom. The plurality of decoders **514**, **516** and **518** are configured to receive the digital signals from the plurality of comparators **508**, **510** and **512**, and to convert the received signals into a code format, for example, a code format that is adapted to a digital logic circuit, to thereby generate converted digital signals.
25 Finally, the synchronizing circuit **522** is configured to receive the internal clock signal **ICLK** from the clock buffer **520**, and the digital output signals **PO1...PO(N)** from the plurality of comparators **508**, **510** and **512**, to generate the respective delayed clock signals **DCLK1...DCLK(N)** therefrom.

Henceforth, an operational example of a multi-process A/D converter
30 according to some embodiments of the present invention as shown in FIG. 5 will be described.

As shown in FIG. 5, the multi-process A/D converter receives an analog input signal **SI**, for example, from an external terminal, and converts the received signal **SI** into digital signals via multiple (at least two) paths comprised of a plurality of process

routines **502**, **504** and **506**, a plurality of comparators **508**, **510** and **512**, and a plurality of decoders **514**, **516** and **518**, to thereby generate an n-bit digital output signal **DO[0:n-1]** therefrom.

The plurality of comparators **508**, **510** and **512** respectively connected to the plurality of process routines **502**, **504** and **506** generate A/D-converted digital signals **PO1-PO(N)** therefrom. The A/D-converted digital signals **PO1-PO(N)** are fed back by the synchronizing circuit **522**, so that the delayed clock signals **DCLK1-DCLK(N)** are generated from the synchronizing circuit **522**, and then applied to the decoders **514**, **516** and **518** respectively corresponding to the process routines **502**, **504** and **506**. Digital signals **DO[0:i-1]-DO[m:n-1]** generated from the decoders **514**, **516** and **518** respectively corresponding to the process routines **502**, **504** and **506** constitute the n-bit digital output signal **DO[0:n-1]**. The analog input signal **SI** propagates with different time delays while passing through the different signal paths, so that it may be distorted with different patterns from each other.

The synchronizing circuit **522** receives the respective output signals **PO1-PO(N)** from the comparators **508**, **510** and **512**, and detects phases of the received digital signals **PO1-PO(N)**, to thereby generate the delayed clock signals **DCLK1-DCLK(N)**, which can have time delays different from one another. The delayed clock signals **DCLK1-DCLK(N)** are applied to the comparators respectively corresponding to the process routines. Each of the comparators **508**, **510** and **512** compares the analog signal from the process routine with a reference voltage under the control of one of the delayed clock signals **DCLK1-DCLK(N)**, to thereby output the digital signal **PO1-PO(N)** therefrom. Thus, upon comparing the analog input signal with the reference voltage, the analog input signal is synchronized to the delayed clock signals **DCLK1-DCLK(N)**. Similarly, the comparators on respective paths are controlled by the delayed clock signals **DCLK1-DCLK(N)** which can have time delays different from one another, so that the erroneous signals themselves generated due to the synchronization to the same internal clock signal can be reduced or corrected, thereby allowing reduced distortion of the analog input signals.

FIG. 6 is a block diagram illustrating multi-process A/D converters comprised of folding/interpolation and flash process routines according to other embodiments of the present invention, and illustrates a detailed structure of a synchronizing circuit according to some embodiments of the present invention.

Referring to FIG. 6, the multi-process A/D converter comprises a clock buffer **650** for receiving and buffering an external clock signal **CLK** from, for example, an external terminal, and generating an internal clock signal **ICLK** therefrom. A folding/interpolation process routine **610** receives and folds an analog input signal **SI**,
 5 and generates a plurality of analog signals with phases different from one another by an interpolation therefrom. A comparator **630** receives output signals of the folding/interpolation process routine **610** and compares an analog signal with a reference voltage under the control of a delayed clock signal **DCLK1**, thereby generating a digital signal **PO1** therefrom. A flash process routine **620** receives and
 10 processes the analog input signal **SI**. A comparator **640** receives the output signal of the flash process routine **620** and compares an analog signal with the reference voltage under the control of a delayed clock signal **DCLK2**, thereby generating a digital signal **PO2** therefrom. A decoder **670** receives the internal clock signal **ICLK** from the clock buffer **650** and the output signals **PO1**, **PO2** from the comparators **630**
 15 and **640**, and converts the received signals into signals having a code format adapted to a digital logic circuit. A synchronizing circuit **660** receives the internal clock signal **ICLK** from the clock buffer **650** and the output signals **PO1**, **PO2** from the comparators **630** and **640**, thereby to generate delayed clock signals **DCLK1**, **DCLK2** therefrom.

20 In some embodiments, the synchronizing circuit **660** comprises a phase detector **668** for receiving the digital signals **PO1**, **PO2** from the comparators **630** and **640** and detecting phases of the received signals **PO1**, **PO2**, to thereby generate a signal **PDO** therefrom. A delay controller **664** receives the output signal **PDO** from the phase detector **668** and generates time delay control signals **DCO1**, **DCO2**
 25 corresponding to a phase difference therefrom. A delay chain part **662** receives the internal clock signal **ICLK** from the clock buffer **650** and thereby generates the delayed clock signal **DCLK1** therefrom, under the control of the time delay control signal **DCO1**. Finally, a delay chain part **666** receives the internal clock signal **ICLK** from the clock buffer **650** and generates the delayed clock signal **DCLK2** therefrom,
 30 under the control of the time delay control signal **DCO2**.

Hereinafter, an operational example of the multi-process A/D converter according to embodiments of the present invention as illustrated in FIG. 6 will be described.

Referring to FIG. 6, the A/D converter receives an analog input signal **SI** from, for example, the external terminal and converts the received analog signal **SI** into the digital signals via both paths of the folding/interpolation process routine **610** and the flash process routine **620**, to thereby generate a digital output signal **DO** of a desired bit number. In the A/D converter of FIG. 6, the analog input signal **SI** propagates with different time delays while passing through the different paths, so that it may be distorted with different patterns from one another. The synchronizing circuit **660** receives the respective output signals **PO1**, **PO2** from the comparators **630** and **640**, detecting phases of the signals **PO1**, **PO2**, and thereby generating the delayed clock signals **DCLK1**, **DCLK2** which may have the time delays different from each other. The delayed clock signals **DCLK1**, **DCLK2** are respectively applied to the comparators **630** and **640** respectively connected to the folding/interpolation process routine **610** and the flash process routine **620**. Each comparator **630** and **640** compares the analog input signal **SI** with the reference voltage under the control of one of the delayed clock signals, thereby generating the digital signal **PO1**, **PO2** therefrom. Thus, upon comparing the analog input signal with the reference voltage, the analog input signal is synchronized to the delayed clock signals **DCLK1**, **DCLK2**. Similarly, the comparators in respective paths are controlled by the delayed clock signals **DCLK1**, **DCLK2** which may have time delays different from each other, so that the erroneous signals themselves generated due to the synchronization to the same internal clock signals can be corrected thereby reducing distortion of the analog input signals.

FIG. 7 is a logic diagram illustrating embodiments of a synchronizing circuit of FIG. 6 using a logic circuit. In FIG. 7, reference number **710** indicates the phase detector, **720** indicates the delay controller comprised of a plurality of shift registers, **730** indicates the delay chain part, and **740** indicates the clock buffer. In some embodiments, the phase detector **710** is comprised of a plurality of D-flip-flops and an exclusive OR logic **716**, and the delay controller **720** is comprised of a plurality of NAND circuits and the plurality of D-flip-flops. The delay chain part **730** is comprised of a plurality of NAND circuits and a plurality of delay cells **DC1-DC8**.

A multi-process A/D converter in accordance with embodiments of the present invention as shown in FIG. 6 can use a delay controller **720** and a delay chain part **730** for each process routine. The phase detector **710** detects the phases of input signals **A**, **B** and transmits detected phase differences to the delay controller **720** comprised of

the shift registers. When the phase detector **710** generates the phase difference therefrom, the delay controller **720** controls the time delay of the delayed clock signal by increasing or decreasing the number of the delay cells **DC1 - DC8**.

5 As described above, multi-process A/D converters and methods in accordance with some embodiments of the present invention can reduce or correct an erroneous signal that is itself generated during synchronization of the input signal to the same internal clock signal by using the delayed clock signal. The output signals of respective paths may thereby be synchronized and distortion of the output signals may be reduced.

10 In the drawings and specification, there have been disclosed embodiments of the invention and, although specific terms are employed, they are used in a generic and descriptive sense only and not for purposes of limitation, the scope of the invention being set forth in the following claims.